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FCC PART 90

TEST REPORT

APPLICANT	Qual-Tron, Inc.
	9409 E. 55h PLACE SOUTH
	TULSA OK 74145-8157 USA
FCC ID	OGE-QTIMIDSHBMCCT
PRODUCT DESCRIPTION	MCDT TRANSMITTER - HIGH CHANNEL
DATE SAMPLE RECEIVED	9/8/2010
DATE TESTED	10/22/2010
TESTED BY	Joe Scoglio
APPROVED BY	Mario R. de Aranzeta
TIMCO REPORT NO.	2147AT10TestReport.doc
TEST RESULTS	<input checked="" type="checkbox"/> PASS <input type="checkbox"/> FAIL

THE ATTACHED REPORT SHALL NOT BE REPRODUCED EXCEPT IN FULL
WITHOUT THE WRITTEN APPROVAL OF TIMCO ENGINEERING, INC.



Certificate # 0955-01



TABLE OF CONTENTS

GENERAL REMARKS.....	3
GENERAL INFORMATION	4
EQUIPMENT LIST.....	5
TEST PROCEDURE	6
RF POWER OUTPUT	7
MODULATION CHARACTERISTICS	8
VOICE MODULATED COMMUNICATION EQUIPMENT	8
OTHER MODULATION CHARACTERISTICS	9
OCCUPIED BANDWIDTH.....	10
SPURIOUS EMISSIONS AT ANTENNA TERMINALS (CONDUCTED).....	12
FIELD STRENGTH OF SPURIOUS EMISSIONS	15
FREQUENCY STABILITY.....	17
FREQUENCY STABILITY.....	18

Applicant: Qual-Tron, Inc.

FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

GENERAL REMARKS

The attached report shall not be reproduced except in full without the written permission of Timco Engineering Inc.

Summary

The device under test does:

- Fulfill the general approval requirements as identified in this test report
- Not fulfill the general approval requirements as identified in this test report

Attestations

This equipment has been tested in accordance with the standards identified in this test report. To the best of my knowledge and belief, these tests were performed using the measurement procedures described in this report.

All instrumentation and accessories used to test products for compliance to the indicated standards are calibrated regularly in accordance with ISO 17025 requirements.



Testing Certificate # 0955-01

I attest that the necessary measurements were made, under my supervision, at:

Timco Engineering Inc.
849 NW State Road 45
Newberry, FL 32669



Authorized Signatory Name:

Mario de Aranzeta C.E.T.
Compliance Engineer/ Lab. Supervisor

Date: 12/1/2010

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FCC ID: OGE-QTIMIDSHBMCCT
Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

GENERAL INFORMATION

DUT Specification

DUT Description	MCDT TRANSMITTER - HIGH CHANNEL
FCC ID	OGE-QTIMIDSHBMC DT
Operating Frequency	162.0-174.0
Type of Emission	11K0F1D
Modulation	FM
DUT Power Source	<input type="checkbox"/> 110-120Vac/50- 60Hz
	<input checked="" type="checkbox"/> DC Power 9V
	<input type="checkbox"/> Battery Operated Exclusively
Test Item	<input type="checkbox"/> Prototype
	<input checked="" type="checkbox"/> Pre-Production
	<input type="checkbox"/> Production
Type of Equipment	<input checked="" type="checkbox"/> Fixed
	<input type="checkbox"/> Mobile
	<input type="checkbox"/> Portable
Test Conditions	The temperature was 26°C relative humidity of 50%.
Modification to the DUT	None
Test Exercise	The DUT was placed in continuous transmit mode.
Applicable Standards	ANSI/TIA 603-C:2004, FCC CFR 47 Part 90
Test Facility	Timco Engineering Inc. at 849 NW State Road 45 Newberry, FL 32669 USA.

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FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc



EQUIPMENT LIST

Device	Manufacturer	Model	Serial Number	Cal/Char Date	Due Date
3-Meter Semi-Anechoic Chamber	Panashield	N/A	N/A	Listed 3/10/10	3/10/12
AC Voltmeter	HP	400FL	2213A14499	CAL 3/23/09	3/23/11
Antenna: Dipole Kit	Electro-Metrics	TDA-30/1-4	153	CHAR 6/10/09	6/10/11
Frequency Counter	HP	5385A	3242A07460	CAL 5/26/09	5/26/11
Hygro-Thermometer	Extech	445703	0602	CAL 1/30/09	1/30/11
Modulation Analyzer	HP	8901A	3435A06868	CAL 5/26/09	5/26/11
Digital Multimeter	Fluke	FLUKE-77-3	79510405	CAL 5/18/09	5/18/11
Analyzer Tan Tower Preamplifier	HP	8449B-H02	3008A00372	CAL 11/21/09	11/21/11
Analyzer Tan Tower Quasi-Peak Adapter	HP	85650A	3303A01690	CAL 11/22/09	11/22/11
Analyzer Tan Tower RF Preselector	HP	85685A	3221A01400	CAL 11/21/09	11/21/11
Analyzer Tan Tower Spectrum Analyzer	HP	8566B Opt 462	3138A07786 3144A20661	CAL 11/24/09	11/24/11
Temperature Chamber	Tenney Engineering	TTRC	11717-7	CHAR 4/25/10	4/25/12

Applicant: Qual-Tron, Inc.

FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc



TEST PROCEDURE

Power Line Conducted Interference: The procedure used was ANSI/TIA 603-C:2004, using a 50uH LISN. Both lines were observed with the UUT transmitting. The bandwidth of the spectrum analyzer was 10 kHz with an appropriate sweep speed.

Bandwidth 20 dB: The measurements were made with the spectrum analyzer's resolution bandwidth (RBW) = 1 MHz and the video bandwidth (VBW) = 3 MHz and the span set as shown on plot.

Power Output: The RF power output was measured at the antenna feed point using a peak power meter.

Antenna Conducted Emissions: The RBW = 100 kHz, VBW = 300 kHz and the span set to 10.0 MHz and the spectrum was scanned from 30 MHz to the 10th harmonic of the fundamental. Above 1 GHz the resolution bandwidth was 1 MHz and the VBW = 3 MHz and the span to 50 MHz.

Radiation Interference: The test procedure used was ANSI/TIA 603-C:2004, using an Agilent spectrum receiver with pre-selector. The bandwidth (RBW) of the spectrum ANSI/TIA 603-C:2004, receiver was 100 kHz up to 1 GHz and 1 MHz above 1 GHz with an appropriate sweep speed. The VBW above 1 GHz was 3 MHz. The analyzer was calibrated in dB above a microvolt at the output of the antenna.

RF POWER OUTPUT

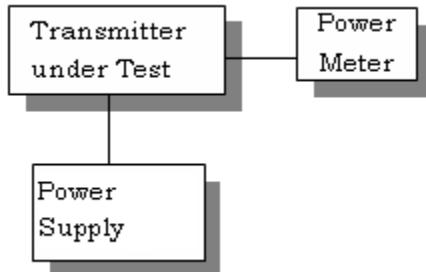
Rule Part No.: Part 2.1046(a), Part 90

Test Requirements:

Method of Measurement: RF power is measured by connecting a 50-ohm, resistive wattmeter to the RF output connector. With a nominal battery voltage, and the transmitter properly adjusted the RF output measures:

For the device has a fixed antenna, RF power is measured as ERP as the antenna is permanently attached. The substitution method was used. With a nominal battery voltage, and the transmitter properly adjusted the RF output measures:

Test Setup Diagram:



Test Data:

OUTPUT POWER: HIGH – 2.0 Watts
LOW - 1.0 Watt

Part 2.1033 (C)(8) DC Input into the final amplifier

FOR LOW POWER SETTING INPUT POWER: $(9.0V)(0.25A) = 2.25$ Watts
FOR HIGH POWER SETTING INPUT POWER: $(9.0V)(0.5A) = 4.5$ Watts

MODULATION CHARACTERISTICS

Rule Part No.: Part 2.1047(a)(b)

Test Requirements:

Method of Measurement:

The audio frequency response was measured in accordance with TIA/EIA Specification 603 with no exception. A curve or equivalent data showing the frequency response of the audio modulating circuit over a range of 100 – 5000Hz shall be submitted. The audio frequency response curve is shown below.

N/A

VOICE MODULATED COMMUNICATION EQUIPMENT

Part 2.1047(a): For equipment required to have an audio low-pass filter, a curve showing the frequency response of the filter, or of all the circuitry installed between the modulation limiter and the modulated stage shall be submitted.

AUDIO INPUT VERSUS MODULATION

Rule Part No.: Part 2.1047(b) & 90

Test Requirements:

Method of Measurement: **Modulation cannot exceed 100%,** The audio input level needed for a particular percentage of modulation was measured in accordance with ANSI/TIA 603-C: 2004. The audio input curves versus modulation are shown below. Curves are provided for audio input frequencies of 300, 1000, and 3000 Hz.

DATA RADIO – NOT APPLICABLE FOR DUT

Applicant: Qual-Tron, Inc.

FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc



OTHER MODULATION CHARACTERISTICS

Part 2.1033(c)

Part 2.1033(c) (4) Type of Emission: 11K2F1D

Part 90.209

Part 90.207 $B_n = 2M + 2DK$

$$M = B/2 = 9600/2 = 4800$$

$$D = 800$$

$$K=1$$

$$B_n = 2(4800) + 2(800) = 11.2k$$

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FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

OCCUPIED BANDWIDTH

Part 2.1049(c) EMISSION BANDWIDTH: Part 90.210(b) 25kHz Channel Spacing

Data in the plots show that on any frequency removed from the assigned frequency by more than 50%, but not more than 100%: At least 25dB. On any frequency removed from the assigned frequency by more than 100%, but not more than 250%: At least 35 dB. On any frequency removed from the assigned frequency by more than 250%, of the authorized bandwidth: At least $43 + 10\log(P)$ dB.

Part 90.210(c) 12.5kHz Channel Spacing Not Equipped with a Low Pass Filter

For transmitters that are not equipped with an audio low pass filter pursuant to S90.211 (b), the power of any emission must be attenuated below the un-modulated carrier output power as follows; (1) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (fd in kHz) of more than 5 kHz but not more than 10 kHz: At least $83 \log(fd/5)$ dB; (2) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (fd in kHz) of more than 10 kHz, but not more than 250% of the authorized bandwidth: At least $29 \log(fd^2/11)$ dB or 50 dB, whichever is the lesser attenuation; (3) On any frequency removed from the center of the authorized bandwidth by more than 250% of the authorized bandwidth: At least $43 + 10 \log(P)$ dB.

Part 90.210(d) Emission Mask D - 12.5 kHz channel BW equipment.

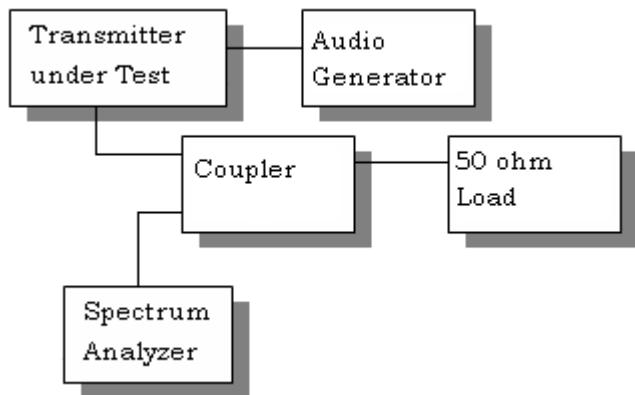
For transmitters designed to operate with a 12.5 kHz channel bandwidth, any emission must be attenuated below the power (P) of the highest emission contained within the authorized bandwidth as follows:

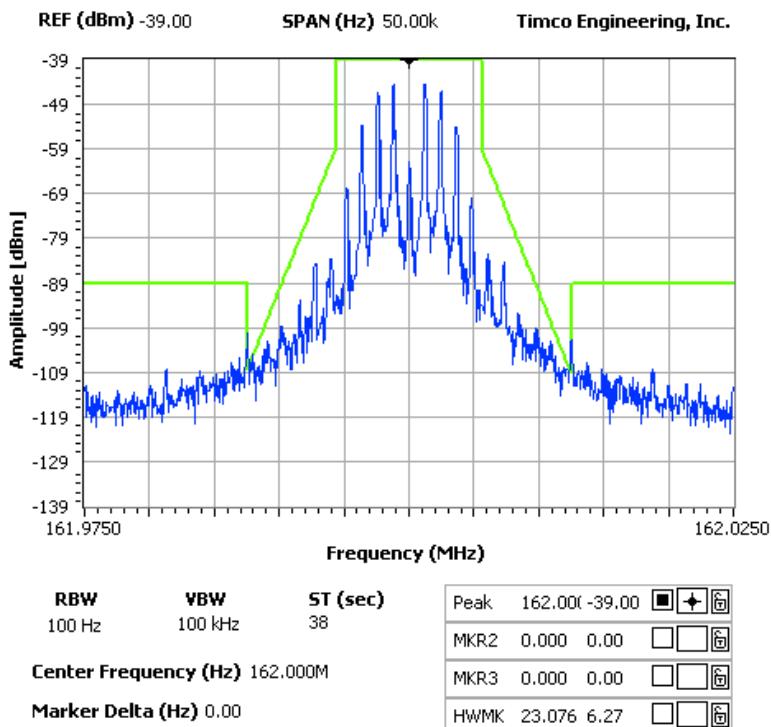
- (1) On any frequency from the center of the authorized bandwidth f0 to 5.625 kHz removed from f0: Zero dB.
- (2) On any frequency from the center of the authorized bandwidth by a displacement frequency (fd in kHz) of more than 5.625 kHz but no more than 12.5 kHz: At least $7.27(fd - 2.88)$ dB.
- (3) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (fd in kHz) of more than 12.5 kHz: At least $50 + 10\log(P)$ dB or 70 dB, whichever is the lesser attenuation.

Part 90.210(e) Emission Mask E - 6.25 kHz channel BW equipment.

For transmitters designed to operate with a 6.25 kHz bandwidth, any emission must be attenuated below the power (P) of the highest emission contained within the authorized bandwidth as follows:

- (1) On any frequency from the center of the authorized bandwidth f0 to 3.0 kHz removed from f0: Zero dB.
- (2) On any frequency from the center of the authorized bandwidth by a displacement frequency (fd in kHz) of more than 3.0 kHz but no more than 4.6 kHz: At least $30 + 16.67(fd - 3.0)$ dB or $55 + 10 \log(P)$ or 65, whichever is the lesser attenuation.
- (3) On any frequency removed from the center of the authorized bandwidth by more than 4.6 kHz: At least $55 + 10\log(P)$ dB or 65 dB, whichever is the lesser attenuation.

Method of Measurement: ANSI/TIA 603-C: 2004
Test Setup Diagram:

Test Data: See plot

NOTES:
FCC 90.210 Mask D


Applicant: Qual-Tron, Inc.

FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

SPURIOUS EMISSIONS AT ANTENNA TERMINALS (CONDUCTED)

Rule Part No.: Part 2.1051(a)

Requirements: 25 kHz Channel Spacing = $43+10\log(2) = 46.0$ dBc
 12.5 kHz Channel Spacing = $50+10\log(2) = 52.0$ dBc

Method of Measurement: The carrier was modulated 100% using a 2500 Hz tone. The spectrum was scanned from 0.4 to at least the 10th harmonic of the fundamental. The measurements were made in accordance with standard ANSI/TIA 603-C: 2004.

Test Data:

TF HIGH POWER	EF	dB below carrier		TF LOW POWER	EF	dB below carrier
162	162	0		162	162	0
	324	66.4			324	67.6
	486	69.3			486	71.6
	648	70.1			648	70.8
	810	76.5			810	73.9
	972	82.5			972	86.6
	1134	75.3			1134	80.6
	1296	87.7			1296	88.6
	1458	90			1458	88
	1620	94.5			1620	94.9

TF HIGH POWER	EF	dB below carrier		TF LOW POWER	EF	dB below carrier
168	168	0		168	168	0
	336	70.9			336	72.4
	504	64.9			504	69.3
	672	72.3			672	70.4
	840	67.4			840	70.9
	1008	73.4			1008	75
	1176	80.4			1176	77.8
	1344	81.3			1344	87.6
	1512	89			1512	91.3
	1680	93			1680	92.6

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FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

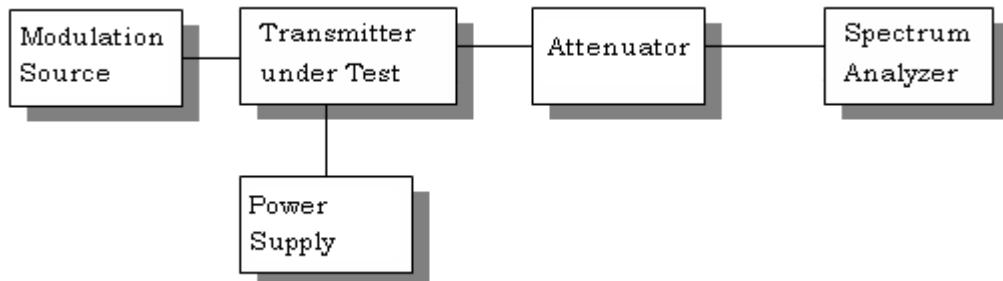
TF HIGH POWER	EF	dB below carrier		TF LOW POWER	EF	dB below carrier
174	174	0		174	174	0
	348	61			348	62.5
	522	63.5			522	66
	696	68.9			696	70.4
	870	70.4			870	71
	1044	67.1			1044	71.1
	1218	73.9			1218	74.6
	1392	82			1392	79.3
	1566	86.4			1566	88.5
	1740	93.7			1740	93.3

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FCC ID: OGE-QTIMIDSHBMCCT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

Method of Measuring Conducted Spurious Emissions



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FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

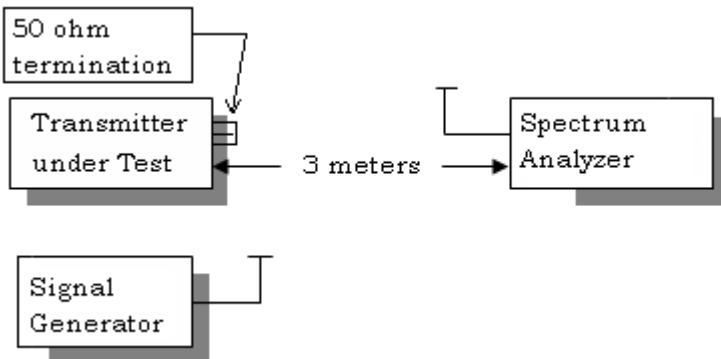
FIELD STRENGTH OF SPURIOUS EMISSIONS

Rule Parts. No.: Part 2.1053

Requirements: 25 kHz Channel Spacing = $43 + 10\log(2) = 46.0$ dBc
 12.5 kHz Channel Spacing = $50 + 10\log(2) = 52.0$ dBc

METHOD OF MEASUREMENT: The tabulated data shows the results of the radiated field strength emissions test. The spectrum was scanned from 30 MHz to at least the tenth harmonic of the fundamental. This test was conducted per ANSI/TIA 603-C: 2004 using the substitution method. Measurements were made at the test site of TIMCO ENGINEERING, INC. located at 849 NW State Road 45, Newberry, FL 32669.

Test Setup Diagram:



Test Data:

HIGH POWER

TF	EF	Ant Polarity	dB below carrier
162.00	324.00	V	100.21
	486.00	V	86.97
	648.00	V	92.63
	810.00	V	97.72
	972.00	V	97.28
	1296.00	H	88.35

LOW POWER

TF	EF	Ant Polarity	dB below carrier
162.00	324.00	V	101.31
	486.00	V	88.27
	648.00	H	97.23
	810.00	V	94.52
	972.00	H	93.68
	1296.00	H	84.85

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FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

TEST DATA CONT'D.
HIGH POWER

TF	EF	Ant Polarity	dB below carrier
168.00	336.00	V	96.95
	504.00	V	84.25
	672.00	V	91.73
	840.00	V	96.33
	1008.00	H	85.82
	1176.00	H	89.22

LOW POWER

TF	EF	Ant Polarity	dB below carrier
168.00	336.00	H	102.15
	504.00	V	83.55
	672.00	V	90.83
	840.00	V	95.73
	1008.00	H	84.72
	1176.00	H	87.12

HIGH POWER

TF	EF	Ant Polarity	dB below carrier
174.00	348.00	H	93.42
	522.00	V	74.80
	696.00	V	91.22
	870.00	H	95.94
	1044.00	V	93.09
	1218.00	V	90.53

LOW POWER

TF	EF	Ant Polarity	dB below carrier
174.00	348.00	H	92.12
	522.00	H	78.10
	696.00	V	90.12
	870.00	V	91.74
	1044.00	V	90.79
	1218.00	V	88.53

Applicant: Qual-Tron, Inc.

FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

FREQUENCY STABILITY

Rule Parts. No.: Part 2.1055, Part 90.213

Requirements: Temperature range requirements: -30 to +50° C.
 Voltage Variation +, -15%
 ±2.5 PPM

Method of Measurements: ANSI/TIA 603-C: 2004.

Test Data:

Assigned Frequency (Ref. Frequency) (MHz)		Frequency Stability (PPM)
Temperature (°C)	Frequency (MHz)	
-30	161.999882	-0.16
-20	161.999885	-0.14
-10	161.999969	0.38
0	162.000008	0.62
+10	162.000046	0.85
+20	161.999968	0.37
+30	161.999891	-0.10
+40	161.999818	-0.56
+50	161.99974	-1.04

Assigned Frequency (Ref. Frequency) (MHz)		Frequency Stability (PPM)
% Battery	Frequency (MHz)	
-15%	161.999907	-0.01
0	161.999908	
+15%	161.999922	0.09

FREQUENCY STABILITY

Part 90.214 Transient Frequency Behavior

REQUIREMENTS: Transmitters designed to operate in the 150-174 MHz and 421-512 MHz frequency bands must maintain transient frequencies within the maximum transient frequencies within the maximum frequency difference limits during the time intervals indicated:

Time Intervals	Maximum frequency difference	All Equipment	
		150-174 MHz	421-512 MHz

Transient Frequency Behavior for Equipment Designed to Operate on 25 kHz Channels

t_1^4	± 25.0 kHz	5.0 ms	10.0 ms
t_2	± 12.5 kHz	20.0 ms	25.0 ms
t_3^4	± 25.0 kHz	5.0 ms	10.0 ms

Transient Frequency Behavior for Equipment Designed to Operate on 12.5 kHz Channels

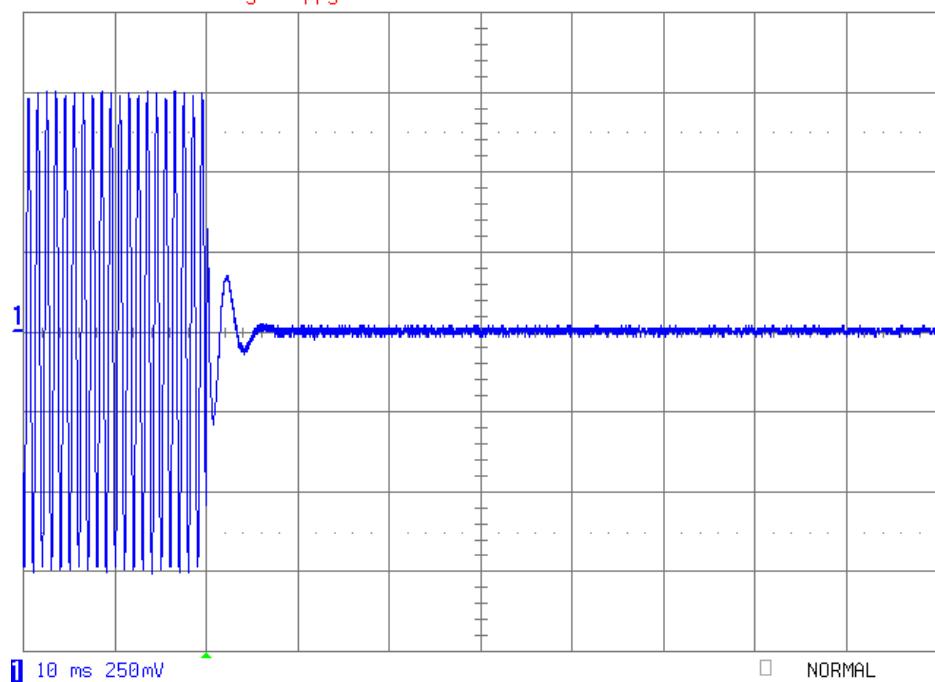
t_1^4	± 12.5 kHz	5.0 ms	10.0 ms
t_2	± 6.25 kHz	20.0 ms	25.0 ms
t_3^4	± 12.5 kHz	5.0 ms	10.0 ms

Transient Frequency Behavior for Equipment Designed to Operate on 6.25 kHz Channels

t_1^4	± 6.25 kHz	5.0 ms	10.0 ms
t_2	± 3.125 kHz	20.0 ms	25.0 ms
t_3^4	± 6.25 kHz	5.0 ms	10.0 ms

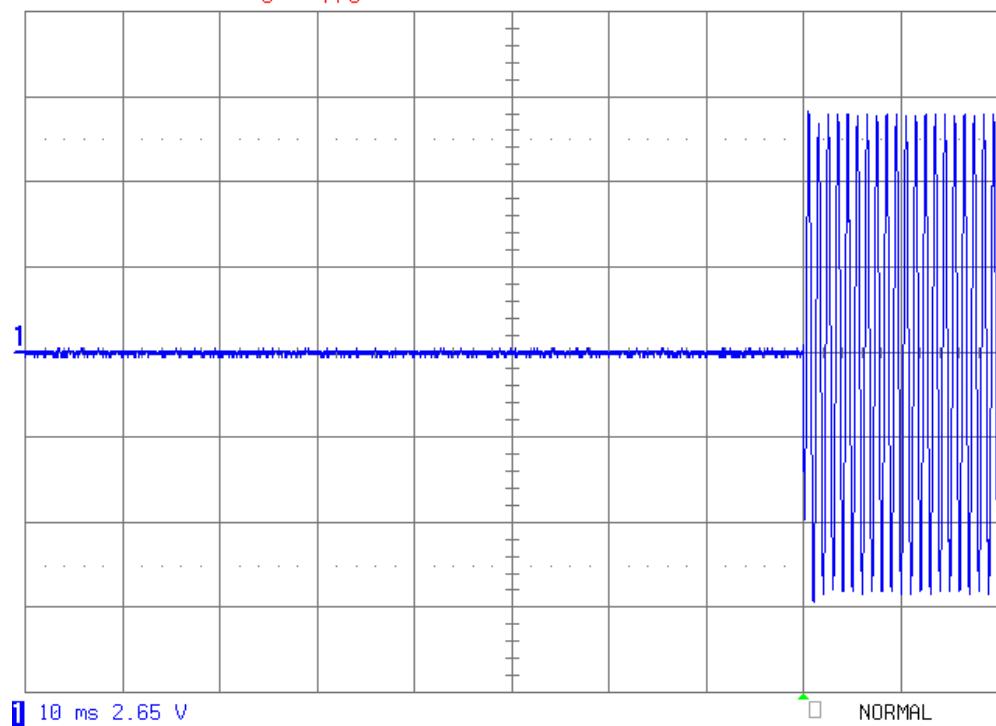
On-Time

Reading Floppy Disk Drive



Off-Time

Reading Floppy Disk Drive



Applicant: Qual-Tron, Inc.

FCC ID: OGE-QTIMIDSHBMC DT

Report: \Q\Qual_Tron\2147AT10\2147AT10TestReport.doc

TEST PROCEDURE: ANSI/TIA 603-C:2004, the levels were set as follows:

1. Using the variable attenuator the transmitter level was set to 40 dB below the test receivers maximum input level, then the transmitter was turned off.
2. With the transmitter off the signal generator was set 20dB below the level of the transmitter in the above step, this level will be maintained with the signal generator through-out the test.
3. Reduce the attenuation between the transmitter and the RF detector by 30 dB.
4. With the levels set as above, the transient frequency behavior was observed and recorded.

